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U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE ATTY. DOCKET NO. SERIAL NO. MI22-587 09/118,359 JIST OF ART CITED BY APPLICANT **APPLICANT** J. Dennis Keller et al. (Use several sheets if necessary) JUL 0 7 2000 FILING DATE July 17, 1998 GROUP 2823 U.S. PATENT DOCUMENTS TRADE *Examiner Initial Document Date Name Class Subclass . Filing Date If Appropriate Number 184A 6,008,517 12/28/99 ΑB AC AD BEST AVAILABLE COPY ΑE AF ÀĞ AH AI AJ AK FOREIGN PATENT DOCUMENTS Document Date Country Class Subclass Translation Number Yes No AL 10-135358 05/22/98 Japan AM AN AO AP OTHER REFERENCES (including Author, Title, Date, Pertinent Pages, Etc.) Solid State Electronic Devices, Ben G. Streetman, Solid State Physical Electronics Series, 1972, 5 pages: AR P66 -67 Hook AS

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